

## GBFULL (United Kingdom (GB) Patents Full-Text)

<b>Subject Coverage</b>	All patent-relevant areas of science and technology, i.e., all classes of the International Patent Classification		
<b>File Type</b>	Full-Text		
<b>Features</b>	Thesauri	International Patent Classification (/IPC) Cooperative Patent Classification (/CPC) European Patent Classification (/EPC and /ICO)	
	<a href="#">Alerts (SDIs)</a>	Weekly or monthly (weekly is the default)	
	CAS Registry Number® Identifiers	<input type="checkbox"/>	<a href="#">SLART</a> <input checked="" type="checkbox"/>
	<a href="#">Keep &amp; Share</a>	<input checked="" type="checkbox"/>	Structures <input type="checkbox"/>
	<a href="#">Register Links</a>	<input checked="" type="checkbox"/>	
<b>Record Content</b>	<ul style="list-style-type: none"> <li>• Full-text of patent applications and patent specifications published in the United Kingdom from 1782 onwards.</li> <li>• Patent applications begin in 1982, when the British Intellectual Property Office started to publish applications.</li> <li>• Database records comprise all documents published for one application. Records of the database contain bibliographic data, including patent applicant and inventor information, patent, application and priority application data, IPC, CPC (including CPC combination sets), and EPC classification codes, plus the searchable text of the complete documents, comprising titles, abstracts, description and claims.</li> <li>• Numeric values of 59 physical and chemical properties are searchable in about 20000 variants of the base and additional units within all full-text fields in English</li> <li>• Ultimate Owners are searchable in the field /UO and /UOS.</li> <li>• Standardized and normalized patent assignee names are searched in /PAS and /PAN.</li> <li>• Key terms, indexed and displayed in the field /KT, enhance retrieval of relevant results, and make the evaluation of results more efficient. They are useful to broaden search scope more precisely than Basic Index searches.</li> <li>• Database records comprise all documents published for one application.</li> <li>• Clipped images (mostly front-page images) are also included, if available.</li> <li>• Some of the full-text has been created by Optical Character Recognition (OCR) software. Therefore, characters may be misinterpreted, or portions of the text may be incomplete</li> </ul>		
<b>File Size</b>	<ul style="list-style-type: none"> <li>• More than 3.01 million family records with more than 3.97 million publications (01/2026)</li> <li>• More than 1.99 million front page images from 1893 to present (01/2026)</li> </ul>		
<b>Coverage</b>	Comprehensive 1893 to present, first document from 1782		
<b>Updates</b>	Weekly		
<b>Language</b>	English		
<b>Database Producer</b>	LexisNexis Business Information Solutions B.V. Radarweg 29 1043 NX Amsterdam The Netherlands Copyright Holder		

**Sources** Patent applications and granted patents published by the United Kingdom Intellectual Property Office

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**User Aids**

- Online Helps (HELP DIRECTORY lists all help messages available)
- STNGUIDE

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**Cluster**

- AEROTECH
- ALLBIB
- AUTHORS
- CORPSOURCE
- ENGINEERING
- FULLTEXT
- HPATENTS
- NPS
- PATENTS
- PNTTEXT

[STN Database Cluster](#) information

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## Search and Display Field Codes

If multiple search terms are linked with an AND-operator, all terms are searched in the complete database record, i.e., in all publications referring to one application. For a search in a specific publication of the record, connect the search term and the patent kind code with the (L)-proximity operator, e.g.,  
S BOREHOLE/AB, TI, CLM (L) GBA/PK limits the search to British applications GBA.  
Fields that allow left truncation are indicated by an asterisk (\*).

### General Search Fields

Search Field Name	Search Code	Search Examples	Display Codes
Basic Index* (contains single words from title (TIEN), abstract (ABEN), detailed description (DETDEN), claims (CLMEN), and main claims (MCLMEN), and key terms (KT) fields)	None or /BI	S TRANSISTOR AND ELECTRODE S ACOUSTIC SENSOR S ?TRANSFER?	TIEN, ABEN, DETDEN, CLMEN, MCLMEN, KT
Abstract*	/ABEN (or /AB)	S BOREHOLE/ABEN	ABEN
Accession Number	/AN	S 2403388/AN	AN
Application Country (WIPO code and text)	/AC	S GB/AC	AI
Application Date (1)	/AD	S AD=JAN 2003	AI
Application Kind Code	/AK	S GBA/AK	AI
Application Number (2)	/AP	S GB2000-10050/AP	AI
Application Number Original	/APO	S GB1817326/APO	APO
Application Year (1)	/AY	S AY>=2000	AI
Claims*	/CLMEN (or /CLM)	S DERIVATION/CLMEN	CLMEN
Claims, Claim Groups	/CLM.CG	S OFFICE CHAIR/CLM.CG	CLM.CG, CLMEN, CLM
Claims, Independent Claims	/CLM.IC	S OFFICE CHAIR/CLM.IC	CLM.IC, CLMEN, CLM
Cooperative Patent Classification (3)	/CPC	S C12N0009-1085/CPC	CPC
Cooperative Patent Classification, Action Date	/CPC.ACD	S 20121113/CPC.ACD	CPC.TAB CPC.TAB
Cooperative Patent Classification, Keywords	/CPC.KW	S C12N0009-1085/CPC (S) I/CPC.KW	CPC.TAB
Cooperative Patent Classification, Version	/CPC.VER	S 20130101/CPC.VER	CPC.TAB
Data Entry Date (1)	/DED	S 20181206/DED	DED
Detailed Description (English)	/DETDEN	S OFFICE CHAIR/DETDEN	DETDEN, DETD
Data Update Date (1)	/DUPD	S 20181207/DUPD	DUPD
Detailed Description *	/DETDEN (or /DETD)	S ?DERIVATION/DETDEN	DETDEN
Document Type	/DT (or /TC)	S PATENT/DT	DT
Entry Date (1)	/ED	S 20240715/ED	ED
Entry Date Full-text (1)	/EDTX	S 20181211/EDTX	EDTX
EPC, Keyword Terms	/EPC.KW	S B2A/EPC.KW	EPC
European Patent Classification (3)	/EPC (or /ECLA, /EPCLA)	S A01B0001-02B/EPC	EPC
Field Availability	/FA	S ABEN/FA	FA
ICO (in-computer-only) Classification (3)	/ICO	S M07D0333/ICO	ICO
ICO Keyword Terms	/ICO.KW	S ADD/ICO.KW	ICO
IdT (Indeling der Techniek)	/IDT	S B21K0001-56/IDT	IDT
International Patent Classification (ICM, ICS, IPCI, IPCR) (3)	/IPC	S A01B001/IPC	ICM, ICS, IPCI, IPCR
International Patent Classification (ICM, ICS)	/IC (or /IPCMS)	S A24B/IC	IC, ICM, ICS
Inventor	/IN (or /AU)	S MANDEL WALTER/IN	IN
Inventor, Country (WIPO code and text)	/IN.CNY	S MANDEL?/IN S FR/IN.CNY	IN, IN.CNY

## General Search Fields (cont'd)

Search Field Name	Search Code	Search Examples	Display Codes
IPC, Action Date (1)	/IPC.ACD	S 20051008/IPC.ACD	IPC.TAB
IPC, Keyword Terms	/IPC.KW	S INITIAL/IPC.KW	IPC.TAB
IPC, Reform	/IPC.REF	S A01B0001-16/IPC.REF	IPC.TAB
IPC, Version	/IPC.VER	S 7/IPC.VER	IPC.TAB
IPC Additional	/ICA (or /IPCA)	S A61K0007-00/ICA	ICA
IPC Initial	/ICI (or /IPCIN)	S A61K0007-06/ICI	ICI
IPC Initial	/IPCI	S B21B0001/IPCI	IPCI
IPC Main	/ICM	S A01N001/ICM	ICM
IPC Reclassified	/IPCR	S B21B0001-34/IPCR	IPCR
IPC Secondary	/ICS	S A01B0013-00/ICS	ICS
Key Terms*	/KT	S BIOAVAILABILITY PARAMETER/KT	KT
Language (code and text)	/LA	S EN/LA	LA
Language of Filing (code and text)	/LAF	S ENGLISH/LAF	LAF
Main Claim*	/MCLMEN (or /MCLM)	S ?FRACTURE?/MCLM	MCLMEN
Number of Claims (1)	/CLMN	S 5-7/CLMN	CLMN
Number of Paragraphs in DETD (Detailed Description) (1)	/DETN	S DETN<10	DETN
Patent Assignee (4)	/PA (or /CS)	S BASF AG/PA	PA
Patent Assignee, Country (WIPO code and text)	/PA.CNY	S DE/PA.CNY	PA.CNY
Patent Assignee, Total	/PA.T	S UNIVERSITY NEVADA/PA.T	PA.T
Patent Assignee Normalized (4)	/PAN	S BASF AG/PAN	PAN
Patent Assignee Standardized (4)	/PAS	S BASF AG/PAS	PAS
Patent Country	/PC	S GB/PC	PI
Patent Information Type	/PIT	S "GBA PATENT SPECIFICATION (UNDER NO. 2000000) OR PUBLISHED PATENT APPLICATION (FROM NO. 2000000)"/PIT	PIT
Patent Kind Code	/PK	S GBA/PK	PI
Patent Number (2)	/PN (or /PATS)	S GB2003005/PN	PI
Patent Number Original	/PNO	S GB201301786/PNO	PNO
Patent Number/Kind Code	/PNK	S GB2000003 A/PNK	PI
Physical Properties	/PHP	S VOLT/PHP (S) TOUCH SCREEN/BI	KWIC
Priority Country (WIPO code and text)	/PRC	S AU/PRC	PRN, PRAI
Priority Date (1)	/PRD	S AUSTRALIA/PRC	
Priority Date First (1)	/PRDF	S PRD=APRIL 2 2003	PRN, PRAI
Priority Number Kind Code	/PRK	S 20030402/PRD	
Priority Number (2)	/PRN	S 20000109/PRDF	PRN, PRAI
Priority Number Original	/PRNO	S DEA/PRK	PRN, PRAI
Priority Year (1)	/PRY	S DE2000-10001525/PRN	PRN, PRAI
Priority Year First (1)	/PRYF	S EP12001001/PRNO	PRNO, PRAO
Publication Date (1)	/PD	S 1993/PRY	PRN, PRAI
Publication Year (1)	/PY	S 1993-1994/PRYF	PRN, PRAI
Related Application Country	/RLC	S PD=JAN-FEB 2003	PI
Related Application Date (1)	/RLD	S PY>2003 AND L1	PI
Related Application Number	/RLN	S WO/RLC	RLI
Related Application Type	/RLT	S 20170203/RLD	RLI
Related Application Year (1)	/RLY	S WO 2017-CA24/RLN	RLI
Related Patent Country	/RLPC	S PCT APPLICATION/RLT	RLI
Related Patent Date (1)	/RLPD	S 2017/RLY	RLI
Related Patent Number	/RLPN	S WO/RLPC	RLPI
Related Patent Year (1)	/RLPY	S 20000309/RLPD	RLPI
Title*	/TIEN (or /TI)	S WO2000000008/RLPN	RLPI
		S 2005/RLPY	RLPI
		S FLUID###/TIEN	TIEN

## General Search Fields (cont'd)

Search Field Name	Search Code	Search Examples	Display Codes
Ultimate Owner (4) Ultimate Owner Standardized (4) Update Date (1) Update Date Full-Text (1)	/UO /UOS /UP /UPTX	S BASF/UO S BASF/UOS S JUN 2024/UP S 20240503/UPTX	UO UOS UP UPTX

- (1) Numeric search field that may be searched using numeric operators or ranges.  
 (2) By default, patent numbers, application and priority numbers are displayed in STN Format. To display them in Derwent format, enter SET PATENT DERWENT at an arrow prompt. To reset display to STN Format, enter SET PATENT STN.  
 (3) An online thesaurus is available in this field.  
 (4) Search with implied (S) proximity is available in this field.

## Super Search Fields

Enter a super search code to execute a search in one or more fields that may contain the desired information. Super search fields facilitate crossfile and multifile searching. EXPAND may not be used with super search fields. Use EXPAND with the individual field codes instead.

Search Field Name	Search Code	Fields Searched	Search Examples	Display Codes
Application Number Group	/APPS	AP, APO, PRN, PRNO, RLN	S GB2010-10008/APPS	AI, APO, PRAI, PRAO, APPS
Patent Assignee Group	/PASS	PA, PAN, PAS, PA.T, UO	S BIONTECH/PASS	PA, PAN, PAS, PA.T, UO
Patent Number Group	/PATS	PN, PNO, RLPN	S GB2009000005/PATS	PI, PNO, RLPI

## Property Fields <sup>(1)</sup>

In GBFULL a numeric search for a specific set of physical properties (/PHP) is available within the full-text fields (TI, AB, DETD, CLM, BI). The numeric values are not displayed as single fields, but highlighted within the hit displays.

Use EXPAND/PHP to search for all available physical properties. A search with the respective field codes will be carried out in all database fields with English text. The /PHP index contains a complete list of codes and related text for all physical properties available for numeric search.

Field Code	Property	Unit	Symbol	Search Examples
/AOS	Amount of substance	Mol	mol	S 10 /AOS
/BIR	Bit Rate	Bit/Second	bit/s	S 8000-10000/BIR
/BIT	Stored Information	Bit	Bit	S BIT > 3 MEGABIT
/CAP	Capacitance	Farad	F	S 1-10 MF/CAP
/CATA	Catalytic Activity	Katal	kat	S 1-10/CATA
/CDN	Current Density	Ampere/Square Meter	A/m <sup>2</sup>	S CDN>10 A/M**2
/CMOL	Molarity, Molar Concentration	Mol/Liter	mol/L	S UREA/BI (S) 8/CMOL
/CON	Conductance	Siemens	S	S 1S-3/CON
/DB	Decibel	Decibel	dB	S DB>50
/DEG	Degree	Degree	°	S CYLINDER/BI (S) 45/DEG
/DEN (C)	Density (Mass Concentration	Kilogram/Cubic Meter	kg/m <sup>3</sup>	S 5E-3-10E-3/DEN
/DEQ	Dose Equivalent	Sievert	Sv	S 100/DEQ

Property Fields <sup>(1)</sup> (cont'd)

Field Code	Property	Unit	Symbol	Search Examples
/DOA /DOS (/LD50)	Dosage Dose	Milligram/Kilogram/Day Milligram/Kilogram	mg/kg/day mg/kg	S 100-300/DOA S DOS>0.8
/DV /ECH (/CHA)	Viscosity, dynamic Electric Charge	Pascal * Second Coulomb	Pa*s C	S DV>5000 S 0.0001-0.001/ECH
/ECO (/ECND)	Electrical Conductivity	Siemens/Meter	S/m	S ECO>800 S/M (15A) AQUEOUS
/ELC (/ECC)	Electric Current	Ampere	A	S 1-10/ELC
/ELF (/ECF)	Electric Field	Volt/Meter	V/m	S 200/ELF
/ENE	Energy	Joule	J	S DROPLETS (10A) 40 JOULE - 70 JOULE /ENE
/ERE (/ERES)	Electrical Resistivity	Ohm*Meter	Ohm*m	S ERE>0.1
/FOR	Force	Newton	N	S 50 N /FOR
/FRE (/F)	Frequency	Hertz	Hz	S OSCILLAT?/BI (S) 1- 3/FRE
/IU	International Unit	none	IU	S IU>1000 (P) VITAMIN A
/KV	Viscosity, kinematic	Square Meter/Second	m2/s	S METHYLPOLYSILOXANES/BI (10A) 200-300 CST /KV
/LEN (/SIZ)	Length, Size	Meter	m	S 1-4/LEN
/LUME	Luminous Emittance, Illuminance	Lux	lx	S 10-50/LUME
/LUMF	Luminous Flux	Lumen	Lm	S LUMF>1000
/LUMI	Luminous Intensity	Candela	cd	S LUMI<4
/M	Mass	Kilogram	kg	S ALLOY/BI (30A) 1E-10-1E-5/M
/MCH	Mass to Charge Ratio	none	m/z	S MCH=1
/MFD (/MFS)	Magnetic Flux Density	Tesla	T	S MFD>102
/MFR (/MFL)	Mass Flow Rate	Kilogram/Second	kg/s	S MFR<0.1
/MFST	Magnetic Field Strength	Ampere/Meter	A/m	S 10-20/MFST
/MM (/MW, /MOM)	Molar Mass	Gram/Mol	g/mol	S 2000-3000 G/MOL/MM
/MOLS	Molality of Substance	Mol/Kilogram	mol/kg	S 01.-10 MOL/KG/MOLS
/MVR	Melt Volume Rate, Melt Flow Rate	none	g/10 min	S 3/MVR
/PER	Percent (Proportionality)	none	%	S POLYMER?/AB (5A) 4/PER
/PHV (/PH)	pH Value	pH	pH	S 7.4-7.6/PHV
/POW (/PW)	Power	Watt	W	S "HG-XE-?"/BI (S) 100-200 WATT/POW
/PPM	Parts per million	Ppm	ppm	S 100 PPM /PPM (10A) ADDITIVE/BI
/PRES (/P)	Pressure	Pascal	Pa	S (VACUUM (5A) DISTILL?)/BI (S) 1000-1100/PRES
/RAD	Radioactivity	Becquerel	Bq	S 10-20/RAD
/RES	Electrical Resistance	Ohm	Ohm	S SENSOR /BI (S) 10- 100/RES
/RI	Refractive Index	none		S 3-4/RI
/RSP	Rotational Speed	Revolution/Minute	rpm	S 2 RPM - 100 RPM /RSP (S) ENGINE/BI
/SAR	Area /Surface Area	Square Meter	m2	S PLATE/BI (S) 10 M**2 - 100 M**2 /SAR
/SOL (/SLB)	Solubility	Gram/100 gram	g/100g	S SOL>20 G/100G (5A) WATER

## Property Fields <sup>(1)</sup> (cont'd)

Field Code	Property	Unit	Symbol	Search Examples
/SSAM	Specific Surface Area, Mass	Square Meter/ Kilogram	m <sup>2</sup> /kg	S 1-10/SSAM
/STSC	Surface Tension	Joule /Square Meter	J/m <sup>2</sup>	S 60 J/M**2/STSC
/TCO (/TCND)	Thermal Conductivity	Watt/Meter*Kelvin	W/m*K	S 1/TCO (S) HEAT?
/TEMP (/T)	Temperature	Kelvin	K	S 20-25/TEMP
/TEX	Tex	Gram/Kilometer	g/km	S 1-5/TEX
/TIM	Time	Second	s	S ?INCUB?/BI (10A) 50 S - 150 S /TIM
/VEL (/V)	Velocity	Meter per Second	m/s	S REDUC?/BI (S) 1E-3-5E-3/VEL
/VELA	Velocity, angular	Radian/Second	rad/s	S VELA>10
/VLR	Volumetric Flow Rate	Cubic Meter/Second	m <sup>3</sup> /s	S 1 M**3/S - 2 M**3/S /VLR (S) ABRASIVE
/VOL	Volume	Cubic Meter	m <sup>3</sup>	S 1E-8-2E-8/VOL.EX
/VOLT	Voltage	Volt	V	S TENSION/BI (10A) 5E-3 V <VOLT<7E-3 V

(1) Exponential format is recommended for the search of particularly high or low values, e.g., 1.8E+7 or 1.8E7 (for 18000000) or 9.2E-8 (for 0.000000092).

## International Patent Classification (/IPC) Thesaurus

The IPC-thesaurus is available in the /IPC search field. The classifications, validity and catchwords for the main headings and subheadings from the current (8<sup>th</sup>) edition of the WIPO International Patent Classification (IPC) manual are available. The classifications from the previous editions (1-7) are also available as separate thesauri. To EXPAND and SEARCH in the thesauri for editions 1-7, use the field code followed by the edition number, e.g., /IPC2, for the 2<sup>nd</sup> edition. Catchwords are included only in the thesauri for the 8<sup>th</sup>, 7<sup>th</sup>, 6<sup>th</sup>, and 5<sup>th</sup> editions. All relationship codes can be used with both the EXPAND and SEARCH. commands.

Code	Content	Examples
ADVANCED (ADV)	Advanced codes for the core level IPC code	E A61K0006-02+ADVANCED/IPC
ALL	All associated terms including definitions	E C01C003-00+ALL/IPC
BRO (MAN)	Complete class	E C01C+BRO/IPC
BT	Broader term	E C01F001-00+BT/IPC
CORE (COR)	Core codes for the advanced level IPC code	E G08C0019-22+CORE/IPC
DEF (ED)	Complete definition of the code, level (core, advanced) and IPC manual edition	E C01F001-00+ED/IPC
HIE	Hierarchy terms (all broader and narrower terms)	E C01B003-00+HIE/IPC
INDEX	Complete title of the code	E C01F001-00+INDEX/IPC
KT	Keyword term	E CYANOGEN+KT/IPC
NEXT	All next codes within the same class	E C01C001-00+NEXT/IPC
NEXTn	Next n codes (n = 1,2 ...) within the same class	E C01C001-00+NEXT5/IPC
NT	Narrower terms	E C01C+NT/IPC
PREV	All previous codes within the same class	E C01C001-12+PREV/IPC
PREVn	Previous n codes (n = 1,2 ...) within the same class	E C01C001-12+PREV10/IPC
TI	Complete title (definition) including broader terms	E C01F001-00+TI/IPC

## ECLA (/EPC) and ICO Thesauri

These thesauri are available in the /EPC search field (for ECLA codes) and /ICO search field (for 'in-computer-only' codes). All relationship codes can be used with both the EXPAND and SEARCH commands.

Relationship Code	Content	Search Examples
ALL	All usually required terms including definitions	E C12M0001-34H2+ALL/EPC
AUTO (1)	Automatic relationship	E L32B0310:00+ALL/ICO
BT	Broader terms	E G01J0003-443+AUTO/EPC
DEF	Complete definition of the code and CPC edition	E G01J0003-443+BT/EPC
HIE	Hierarchy terms (all broader and narrower terms)	E SCRAPER BIASING MEANS+CODE/EPC
KT	Keyword term	E B65G0045-16+DEF/EPC
MAX	All associated terms	E A01B0001+HIE/EPC
NEXT	All next codes within the same class	E LASER+KT/EPC
NEXT(n)	Next n codes (n = 1,2 ...) within the same class	E G01J0003-44B+MAX/EPC
NT	Narrower terms	E A01B0001-24+NEXT/EPC
PREV	All previous codes within the same class	E A01B0001-24+NEXT3/EPC
PREV(n)	Previous n codes (n = 1,2 ...) within the same class	E G05B0001-04+NT/EPC
TI	Complete title (definition) including broader terms	E G05B0019-418N1+PREV/EPC
		E G05B0001-03+TI/EPC

(1) Automatic Relationship is SET OFF. In case of SET REL ON the result of EXPAND or SEARCH without any relationship code is the same as described for AUTO.

## CPC Thesaurus

This thesaurus is available in the /CPC search field. All relationship codes can be used with both the EXPAND and SEARCH commands.

Relationship Code	Content	Search Examples
ALL	All usually required terms including definitions	E C12M0001-005+ALL/CPC
AUTO (1)	Automatic relationship	E G01J0003-443+AUTO/CPC
BT	Broader terms	E G01J0003-443+BT/CPC
DEF	Complete definition of the code and CPC edition	E B65G0045-16+DEF/CPC
HIE	Hierarchy terms (all broader and narrower terms)	E A01B0001+HIE/CPC
KT	Keyword term	E LASER+KT/CPC
MAX	All associated terms	E G01J0003-44+MAX/CPC
NEXT	All next codes within the same class	E A01B0001-24+NEXT/CPC
NEXT(n)	Next n codes (n = 1,2 ...) within the same class	E A01B0001-24+NEXT3/CPC
NT	Narrower terms	E G05B0001-04+NT/CPC
PREV	All previous codes within the same class	E G05B0019-00+PREV/CPC
PREV(n)	Previous n codes (n = 1,2 ...) within the same class	E G05B0019-00+PREV2/CPC
TI	Complete title (definition) including broader terms	E G05B0001-03+TI/CPC

(1) Automatic Relationship is SET OFF. In case of SET REL ON the result of EXPAND or SEARCH without any relationship code is the same as described for AUTO.



## DISPLAY and PRINT Formats

Any combination of formats may be used to display or print answers. Multiple codes must be separated by spaces or commas, e.g., D L1 1-5 TI AU. The fields are displayed or printed in the order requested.

The information of the latest publication is displayed by default. To display the content for all levels of the record you can combine all display fields and formats with the qualifier .M except FA, SCAN, and TRIAL.

The default display format is STD.M, i.e., all publication levels of one family in the STD format.

For displaying a particular publication of a database record, you can simply add for certain display field the kind code to the appropriate display format, e.g., ALL.A1. Fields that allow this are indicated by a number **(3)**. Hit-term highlighting is available for all fields. Highlighting must be ON during SEARCH to use the HIT, KWIC, and OCC formats.

Format	Content	Examples
ABEN (AB, ABS)	Abstract	D TI AB 1-5
AI (AP) <b>(1)</b>	Application Information	D AI
AN	Accession Number	D L3 AN
APO (AIO)	Application Number Original	D APO
CLMEN (CLM) <b>(3)</b>	Claims	D CLM
CLM.CG	Claims, Claim Groups	D CLM.CG
CLM.IC	Claims, Independent Claims	D CLM.IC
CLMN <b>(2)</b>	Number of Claims	D CLMN
CPC	Cooperative Patent Classification	D CPC
DED	Data Entry Date	D DED
DETDEN (DETD) <b>(3)</b>	Detailed Description	D DETD
DETN <b>(2)</b>	Number of Paragraphs in DETD	D DETN
DT (TC)	Document Type	D DT
DUPD	Data Update Date	D DUPD
ED	Entry Date	D ED
EDP	Entry Date Patent	D EDP
EDTX	Entry Date of Full-Text	D EDTX
EPC (ECLA, EPCLA)	European Patent Classification	D EPC
FA	Field Availability (for all publication levels)	D FA
GI	Graphic Image	D GI
IC	International Patent Classification (Version 1-7) (ICM, ICS, ICA, ICI)	D IC
ICA (IPCA)	IPC, Additional	D ICA
ICI	IPC Index	D ICI
ICM	IPC Main	D IC
ICO	ICO (in-computer-only) Classification	D ICO
ICS	IPC Secondary	D ICS
IDT	IDT Classification	D IDT
IN (AU)	Inventor	D IN
IN.CNY	Inventor, Country	D IN.CNY
IPC	International Patent Classification (Version 1-8) (IPCI, IPCR, ICM, ICS, ICA, ICI)	D IPC
IPCI	IPC Initial	D IPCI
IPCR	IPC Reclassified	D IPCR
KT	Key Terms	D KT
LA	Language	D LA
LAF	Language of Filing	D LAF
MCLMEN (MCLM)	Main Claim	D MCLM
PA (CS)	Patent Assignee	D PA
PA.CNY	Patent Assignee, Country	D PA.CNY
PAN	Patent Assignee Normalized	D PAN
PAS	Patent Assignee Standardized	D PAS
PI (PN) <b>(1)</b>	Patent Information	D PI
PIT	Patent Information Type	D PIT
PNK	Patent Number/Kind Code	D PNK
PNO <b>(2)</b>	Patent Number Original	D PNO
PRAI (PRN) <b>(1, 5)</b>	Priority Information	D PRN
PRAO (PRNO) <b>(2)</b>	Priority Information Original	D PRNO
RLI (RLN)	Related Application Information	D RLI
RLPI	Related Patent Information	D RLPI

**DISPLAY and PRINT Formats (cont'd)**

Format	Content	Examples
TIEN (TI) UO UOS UP UPTX	Title Ultimate Owner Ultimate Owner Standardized Update Date Update Date Full-Text	D TIEN D UO D UOS D UP D UPTX
ALL (1, 3)  ALLG (1) DALL (1) IALL (1, 3) IALLG (1) APPS (1) BIB (1)  BIBG (1) IBIB (1) IBIBG (1) BRIEF (1)  BRIEFG (1, 4) IBRIEF (1) IBRIEFG (1, 4) CPC.TAB IND IPC IPC.TAB MAX (ALL.M) (1)  MAXG (ALLG.M) (1) IMAX (IALL.M) (1) IMAXG (IALLG.M) (1) PASS PATS (1) SCAN (4) STD (1)  STDG (1) ISTD (1) ISTDG (1) TRIAL (TRI, SAM, SAMPLE, FREE) TX	AN, EDP, ED, EDTX, UP, DED, DUPD, TIEN, IN, PA, PAS, PAN, UO, UOS, LAF, LA, DT, PIT, PI, AI, RLPI, RLI, PRAI, IPC, CPC, EPC, ICO, IDT, ABEN, DETDEN, CLMEN, KT ALL plus graphic image ALL delimited for post processing ALL indented with text labels IALL plus graphic image AI, RLI, RLPI, PRAI AN, EDP, ED, EDTX, UP, DED, DUPD, TIEN, IN, PA, PAS, PAN, UO, UOS, LAF, LA, DT, PIT, PI, AI, RLPI, RLI, PRAI, IPC, CPC, EPC, ICO, IDT BIB plus graphic image BIB indented with text labels IBIB plus graphic image AN, EDP, ED, EDTX, UP, DED, DUPD, TIEN, IN, PA, PAS, PAN, UO, UOS, LAF, LA, DT, PIT, PI, AI, RLPI, RLI, PRAI, IPC, EPC, ICO, IDT, ABEN, MCLMEN, KT BRIEF plus graphic image BRIEF indented with text labels BRIEFG indented with text labels CPC, CPC.KW, CPC.ACD, CPC.VER in tabular format IPC (ICA, ICI, ICM, ICS, IPCI, IPCR), CPC, EPC, ICO, IDT International Patent Classification (ICA, ICI, ICM, ICS, IPCI, IPCR) IPC, IPC.KW, IPC.ACD, IPC.VER, in tabular version AN, EDP, ED, EDTX, UP, DED, DUPD, TIEN, IN, PA, PAS, PAN, UO, UOS, LAF, LA, DT, PIT, PI, AI, RLPI, RLI, PRAI, IPC, CPC, EPC, ICO, IDT, ABEN, DETDEN, CLMEN, KT, FA for all levels of publication MAX, plus graphic image MAX, indented with text labels IMAX, plus graphic image PA, PAN, PAS, PA.T, UO, UOS PI, PNO, RLPI TI (random display without answer numbers) AN, EDP, ED, EDTX, UP, DED, DUPD, TIEN, IN, PA, PAS, PAN, UO, UOS, LAF, LA, DT, PIT, PI, AI, RLPI, RLI, PRAI, IPC, CPC, EPC, ICO, IDT (STD.M is default) STD, plus graphic image STD, indented with text labels ISTD, plus graphic image AN, EDP, ED, EDTX, UP, UPTX, TIEN, FA, DED, DUPD, DETN, CLMN DETDEN, CLMEN	D ALL  D ALLG D DALL D IALL D IALLG D APPS D BIB  D BIBG D IBIB D IBIBG D BRIEF  D BRIEFG D IBRIEF D IBRIEFG D CPC.TAB D IND D IPC D IPC.TAB D MAX  D MAXG D IMAX D IMAXG D PASS D PATS D SCAN D STD  D STDG D ISTD D ISTDG D TRIAL  D TX
HIT KWIC OCC	Hit term(s) and field(s) Up to 50 words before and after hit term(s) (KeyWord-In-Context) Number of occurrences of hit term(s) and field(s) in which they occur	D HIT D KWIC D OCC

(1) By default, patent numbers, application and priority numbers are displayed in STN Format. To display them in Derwent format, enter SET PATENT DERWENT at an arrow prompt. To reset display to STN Format, enter SET PATENT STN.

(2) Custom display only.

(3) You can combine this display field with the qualifier .PK (Patent Kind Code) to display the content for a certain publication level of a record, e.g., CLM.B2.

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(5) If priority information is not available for a certain document, this information is taken from the application information of this document and marked with an asterisk (\*).

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The SORT command is used to rearrange the search results in either alphabetic or numeric order of the specified field(s).

You can combine all fields except FA with the qualifier .M to SELECT/ANALYZE the content of all publication levels.

Field Name	Field Code	ANALYZE/ SELECT (1)	SORT
Accession Number	AN	Y	Y
Application Country	AC	Y	Y
Application Date	AD	Y	Y
Application Information Group	APPS	Y	Y
Application Kind Code	AK	Y (3)	Y
Application Number	AP (AI)	Y (2)	Y
Application Number Original	APO	Y	Y
Application Year	AY	Y	Y
CPC Classification	CPC	Y	Y
Data Entry Date	DED	Y	Y
Data Update Date	DUPD	Y	Y
Document Type	DT (TC)	Y	Y
Entry Date	ED	Y	Y
Entry Date Full-Text	EDTX	Y	Y
Entry Date Patent	EDP	Y	Y
European Patent Classification	EPC (ECLA, EPCLA)	Y	N
Field Availability	FA	Y	N
International Patent Classification	IC	Y	N
Inventor	IN (AU)	Y	Y
Inventor, Country	IN.CNY	Y	Y
ICO (in-computer-only) Classification	ICO	Y	Y
IdT (Indeling der Techniek) Classification	IDT	Y	Y
IPC (ICM, ICS, ICA, ICI, IPCI, IPCR)	IPC	Y	Y

**SELECT, ANALYZE, and SORT Fields (cont'd)**

Field Name	Field Code	ANALYZE/ SELECT (1)	SORT
IPC Additional	ICA	Y	Y
IPC, Advanced Level Symbols	IPC.A	Y (4)	N
IPC, Advanced Level Symbols for Invention	IPC.AI	Y (4)	N
IPC, Core Level	IPC.C	Y	N
IPC, Core Level, Invention	IPC.CI	Y	N
IPC, Reform	IPC.REF	Y	N
IPC Secondary	ICS	Y	Y
IPC Initial	ICI	Y	Y
IPC Initial	IPCI	Y	Y
IPC Main	ICM	Y	Y
IPC Reclassified	IPCR	Y	Y
Key Terms	KT	Y	N
Language	LA	Y	Y
Language of Filing	LAF	Y	Y
Number of Claims	CLMN	Y	Y
Number of Paragraphs in DETD	DETN	Y	Y
Occurrence Count of Hit Terms	OCC	N	Y
Patent Assignee	PA (CS)	Y	Y
Patent Assignee, Country	PA.CNY	Y	Y
Patent Assignee, Total	PA.T	Y	Y
Patent Assignee Normalized	PAN	Y	Y
Patent Assignee Standardized	PAS	Y	Y
Patent Country	PC	Y	Y
Patent Information Type	PIT	Y	Y
Patent Kind Code	PK	Y	Y
Patent Number	PN (PI)	Y (default)	Y
Patent Number Group	PATS	Y	Y
Patent Number Original	PNO	Y	Y
Patent Number/Kind Code	PNK	Y (3)	Y
Pre-IPC8 Symbols from the ICM and first IPC8 values from 2006-present	IPC.F	Y	N
Priority Country	PRC	Y	Y
Priority Date	PRD	Y	Y
Priority Date First	PRDF	Y	Y
Priority Number Kind Code	PRK	Y	Y
Priority Number	PRN (PRAI)	Y	Y
Priority Number Original	PRNO	Y	Y
Priority Year	PRY	Y	Y
Priority Year First	PRYF	Y	Y
Publication Date	PD	Y	Y
Publication Year	PY	Y	Y
Related Application Country	RLC	Y	Y
Related Application Number	RLN	Y	Y
Related Application Date	RLD	Y	Y
Related Application Type	RLT	Y	N
Related Application Year	RLY	Y	Y
Related Patent Country	RLPC	Y	Y
Related Patent Number	RLPN	Y (3)	Y
Related Patent Date	RLPD	Y	Y
Related Patent Year	RLPY	Y	Y
Title	TIEN (TI)	Y	Y
Ultimate Owner	UO	Y	Y
Ultimate Owner Standardized	UOS	Y	Y
Update Date	UP	Y	Y
Update Date Full-Text	UPTX	Y	Y

(1) HIT may be used to restrict terms extracted to terms that match the search expression used to create the answer set, e.g., SEL HIT TI.

(2) Selects or analyzes application numbers with /AP appended to the terms created by SELECT.

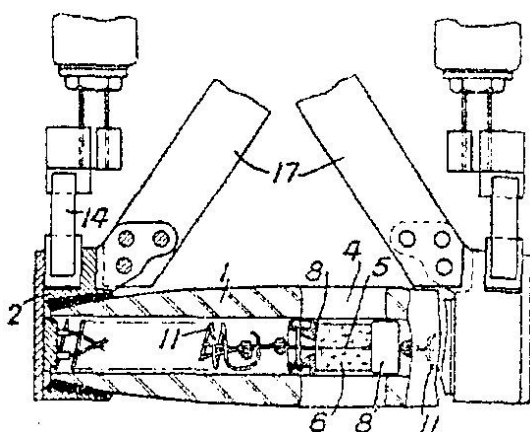
(3) SELECT or ANALYZE HIT are not valid with this field.

(4) Appends /IPC.REF to the terms created by SELECT.

## Sample Records

### DISPLAY MAXG (STN format)

AN 1758406 GBFULL EDP 20140615 ED 20180205 UP 20240701 EDTX 20240701  
DED 20180130 DUPD 20240625 [Full-text](#)  
TIEN Common platform for the encoder and decoder of CEPL codecs  
PA SIEMENS AG  
PAS SIEMENS  
PAN SIEMENS  
LAF English  
DT Patent; (Fulltext)  
PI GB 2004021852 D0 20041103  
PIT GBD0 PATENT APPLICATION FILED  
AI GB 2004-21852 A 20041001  
PRAI GB 2004-21852 20041001  
IPCR G10L0019-12 [I,A]; G10L0019-14 [I,A]; G10L0019-16 [I,A]  
CPC G10L0019-04; G10L0019-12; G10L0019-16  
GI



AB

Equivalent from GB2418818A

A method and an arrangement to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication network, wherein common portions (1 to 4) of said codecs were extracted and implemented on the common platform communicating with the remaining portions (5 to 10) of said codecs.

DETDEN

Equivalent from GB2418818A

A METHOD AND AN ARRANGEMENT TO PROVIDE A COMMON PLATFORM FOR THE ENCODER AND DECODER OF VARIOUS CELP CODECS

#### DESCRIPTION

[DESC0003] The invention relates to a method an arrangement to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication networks.

#### BACKGROUND OF INVENTION

[DESC0005] The presented invention particularly concerns in the development of the VoIP access and trunk gateways. The demands of the customer features are increasing, wherein resources in the gates and memory in used DSP, FPGA or ASIC is limited. Supporting all the features or increasing number of features leads - on the one hand - to more expensive ASIC, FPGA and DSP or lower port density achievement.

...

# SUMMARY OF INVENTION

[DESC0009] The present invention aims to overcome the above mentioned disadvantages.

[DESC0010] Said problem is solved by the features mentioned in the independent claims. Preferred embodiments of the invention are described in the dependent claims.

...

Equivalent from GB2418818A

CLMEN

[CLM0001] 1. A method to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication networks, wherein common portions (1 to 4; 11 to 15) of said codecs were extracted and implemented on the common platform communicating with the remaining portions ( 5 to 10; 16 to 22) of said codecs.

[CLM0002] 2. A method as claimed in the preceding claim, wherein the codecs could be represented by AMR, by Enhanced Full Rate GSM, by G729 or by G723.

...

AN 1758406 GBFULL EDP 20140615 ED 20140615 UP 20240701 EDTX 20140615  
UPTX 20191017  
DUPD 20240625 [Full-text](#)

TIEN A method for providing a common platform for various CELP codecs

IN ARORA NITIN, DE

PA SIEMENS AG, DE

PAS SIEMENS

PAN SIEMENS

UO SIEMENS AG

UOS Siemens

LAF English

LA English

DT Patent; (Fulltext)

PI **GB 2418818** A 20060405

PIT GBA PATENT SPECIFICATION [UNDER NO. 2000000] or PUBLISHED PATENT APPLICATION [FROM NO. 2000000]

AI GB 2004-21852 A 20041001

PRAI GB 2004-21852 20041001

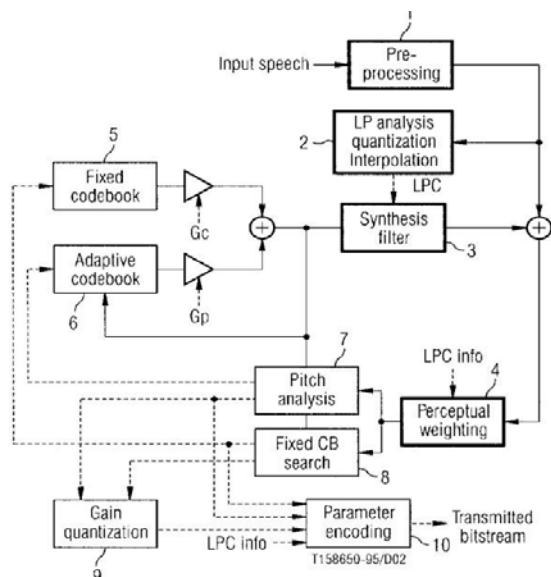
IPCI G10L0019-04 [I,A]

IPCR G10L0019-12 [I,A]; G10L0019-14 [I,A]; G10L0019-16 [I,A]

CPC G10L0019-04; G10L0019-12; G10L0019-16

EPC G10L0019-04; G10L0019-12; G10L0019-16

GI



AB

Original

A method and an arrangement to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication network, wherein common portions (1 to 4) of said codecs were extracted and implemented on the common platform communicating with the remaining portions (5 to 10) of said codecs.

DETDEN

A METHOD AND AN ARRANGEMENT TO PROVIDE A COMMON PLATFORM FOR THE ENCODER AND DECODER OF VARIOUS CELP CODECS

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[DESC0005] The presented invention particularly concerns in the development of the VoIP access and trunk gateways. The demands of the customer features are increasing, wherein resources in the gates and memory in used DSP, FPGA or ASIC is limited. Supporting all the features

...

SUMMARY OF INVENTION

[DESC0009] The present invention aims to overcome the above mentioned disadvantages.

[DESC0010] Said problem is solved by the features mentioned in the independent claims. Preferred embodiments of the invention are described in the dependent claims.

...

[DESC0030] In conclusion implementation, testing efforts and costs are reduced, the port density are diminished and a platform integrating mobile and fixed network codecs in one is provided.

CLMEN

[CLM0001] 1. A method to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication networks, wherein common portions (1 to 4; 11 to 15) of said codecs were extracted and implemented on the common platform communicating with the remaining portions ( 5 to 10; 16 to 22) of said codecs.

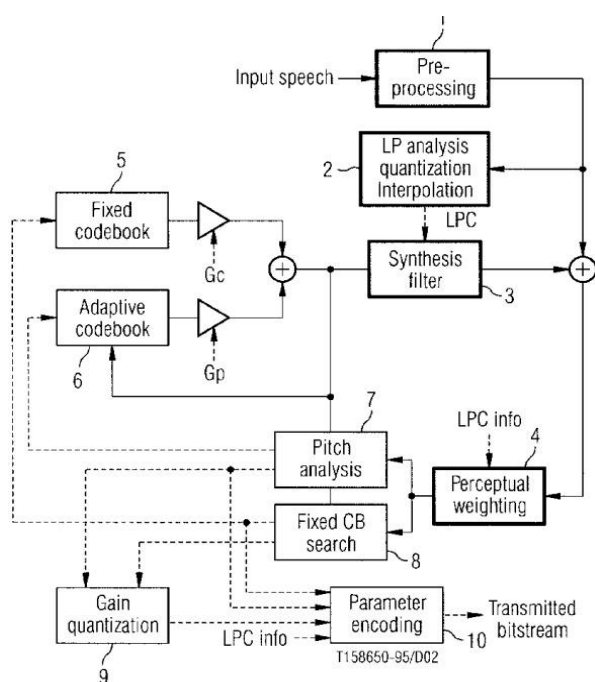
...

[CLM0004] 4. A platform as claimed in the preceding claim , wherein the codecs could be represented by AMR, by Enhanced Full Rate GSM, by G729 or by G723.

AN 1758406 GBFULL EDP 20140615 ED 20140615 UP 20240701 EDTX 20140615  
UPTX 20191016  
DUPD 20240625 [Full-text](#)

TIEN A method and an arrangement to provide a common platform for tencoder and decoder of various CELP codecs

IN	ARORA NITIN, DE
PA	SIEMENS AG, DE
PAS	SIEMENS
PAN	SIEMENS
UO	SIEMENS AG
UOS	Siemens
LAF	English
LA	English
DT	Patent; (Fulltext)
PI	<b>GB 2418818</b> B 20070502
PIT	GBB AMENDED PATENT SPECIFICATION [UNDER NO. 2000000] or PATENT SPECIFICATION [FROM NO. 2000000]
AI	GB 2004-21852 A 20041001
PRAI	GB 2004-21852 20041001
IPCI	G10L0019-04 [I,A]
IPCR	G10L0019-12 [I,A]; G10L0019-14 [I,A]; G10L0019-16 [I,A]
CPC	G10L0019-04; G10L0019-12; G10L0019-16
EPC	G10L0019-04; G10L0019-12; G10L0019-16
GI	



AB

Equivalent from GB2418818A

A method and an arrangement to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication network, wherein common portions (1 to 4) of said codecs were extracted and implemented on the common platform communicating with the remaining portions (5 to 10) of said codecs.

DET DEN

[DESC0001] A method and an arrangement to provide a common platform for the encoder and decoder of various CELP codecs

DESCRIPTION

...

[DESC0030] In conclusion implementation, testing efforts and costs are reduced, the port density are diminished and a platform integrating mobile and fixed network codecs in one is provided.



## CLMEN

[CLM0001] 1. A method to provide a common platform for the encoder and decoder of various CELP codecs used during data/speech transmission within a communication networks, wherein common portions (1 to 4; 11 to 15) of said codecs were extracted and implemented on the common platform communicating with the remaining portions ( 5 to 10; 16 to 22) of said codecs.

## KT

celp codec; fixed network codec; platform integrating mobile; complex celp encoder; communication network; gate requirement; low port density; port density achievement; low bit rate codec; programming difficulty; complex chip design; adaptive code book search; enhanced full rate; celp decoder; voip access; trunk gateway; low complexity causing cost; synthesis filter; high-pass filtering; stage example doing filtering; encoder side; pre-processing block; perceptual weighing filter; memory chip; linear prediction coefficient; high implementation; cost consuming; conclusion implementation; reflection coefficient; ip convergence

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